

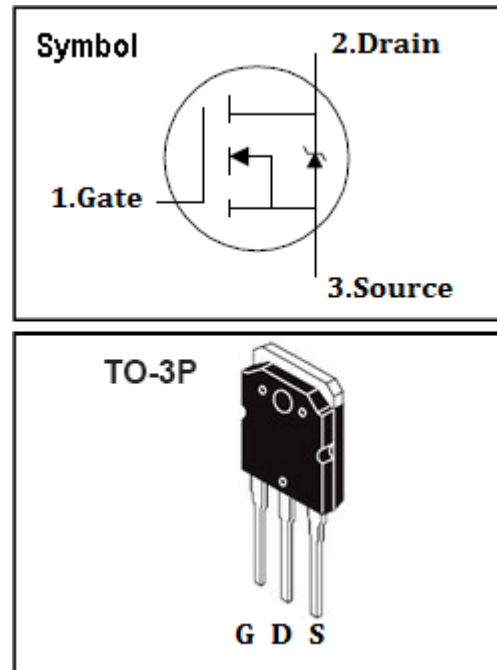
## N-channel MOSFET

### Features

- 900V,9A
- $R_{DS(on)}=1.05\Omega$  @  $V_{GS}=10V, I_D=4.5A$
- High speed switching
- High ruggedness
- 100% avalanche tested
- Improved dv/dt capability

### General Description

KDF9N90A is well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.



### Absolute Maximum Ratings

Symbol	Parameter	Value	Units
$V_{DSS}$	Drain-Source Voltage	900	V
$V_{GS}$	Gate-Source Voltage	$\pm 25$	V
$I_D$	Continuous Drain Current( $T_C=25^\circ C$ )	9	A
$I_{DM}$	Pulsed Drain Current(Note 1 )	36	A
EAS	Single Pulsed Avalanche Energy(Note 2)	900	mJ
dV/dt	Peak Diode Recovery dv/dt(Note 3)	4	V/ns
$P_D$	Maximum Power Dissipation ( $T_C=25^\circ C$ )	280	W
	Maximum Power Dissipation ( $T_C=100^\circ C$ )	112	W
$T_J$	Operating Junction Temperature Range	-55 to +150	$^\circ C$
$T_{STG}$	Storage Temperature Range	-55 to +150	$^\circ C$

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. Starting  $T_J=25^\circ C, L=21mH, R_G=50\Omega, I_D=9A, V_{GS}=10V$
3.  $I_{SD} \leq 9A, di/dt \leq 200A/us, V_{DD} \leq BV_{DSS}$ . Starting  $T_J=25^\circ C$

### Thermal data

Symbol	Parameter	Max.	Units
$R_{th J-C}$	Thermal Resistance, Junction to case	0.45	$^\circ C / W$
$R_{th J-A}$	Thermal Resistance, Junction to ambient	40	$^\circ C / W$

**Electrical Characteristics** ( $T_C=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	900	-	-	V
$I_{DSSS}$	Drain-Source Leakage Current	$V_{DS}=900V, V_{GS}=0V$	-	-	10	$\mu A$
$I_{GSS}$	Gate Leakage Current, Forward	$V_{GS}=25V, V_{DS}=0V$	-	-	100	nA
	Gate Leakage Current, Reverse	$V_{GS}=-25V, V_{DS}=0V$	-	-	-100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\mu A$	2	-	4.5	V
$R_{DS(on)}$	Collector-Emitter Saturation Voltage	$V_{GS}=10V, I_D=4.5A$	-	1.05	-	$\Omega$
$Q_g$	Total Gate Charge	$V_{DD}=720V$ $V_{GS}=10V$ $I_D=9A$	-	45	-	nC
$Q_{gs}$	Gate-Source Charge		-	14	-	nC
$Q_{gd}$	Gate-Drain Charge		-	18	-	nC
$t_{d(on)}$	Turn-on Delay Time	$V_{DS}=450V$ $V_{GS}=10V$ $I_D=9A$ $R_G=25\Omega$	-	50	-	ns
$t_r$	Turn-on Rise Time		-	120	-	ns
$t_{d(off)}$	Turn-off Delay Time		-	100	-	ns
$t_f$	Turn-off Fall Time		-	80	-	ns
$C_{iss}$	Input Capacitance	$V_{DS}=25V$ $V_{GS}=0V$ $f=100kHz$	-	2200	-	pF
$C_{oss}$	Output Capacitance		-	180	-	pF
$C_{rss}$	Reverse Transfer Capacitance		-	15	-	pF

**Source-Drain Ratings and Characteristics** ( $T_C=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$V_{SD}$	Forward On Voltage	$V_{GS}=0V, I_S=9A$	-	-	1.5	V
$I_S$	Continuous Diode Forward Current		-	-	9	A
$I_{SM}$	Maximum Pulsed Drain-Source Diode Forward Current				36	A
$t_{rr}$	Reverse Recovery Time	$V_{GS}=0V, I_S=9A$ $di_f/dt=100A/\mu s$	-	550		ns
$Q_{rr}$	Reverse Recovery Charge		-	6.5		$\mu C$

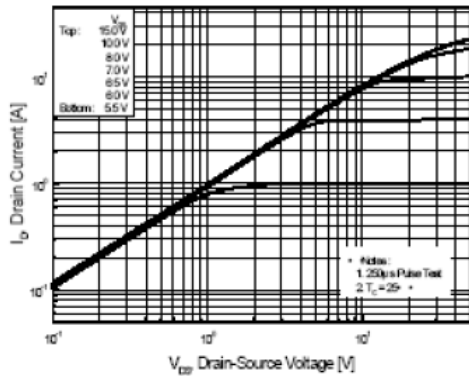


Figure 1. On-Region Characteristics

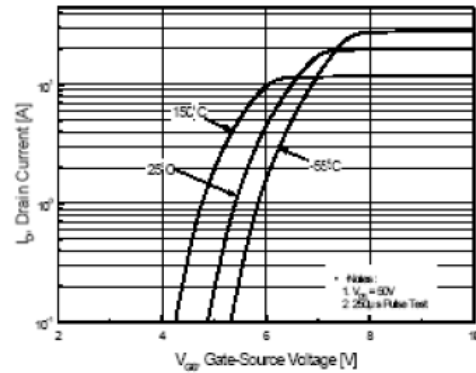


Figure 2. Transfer Characteristics

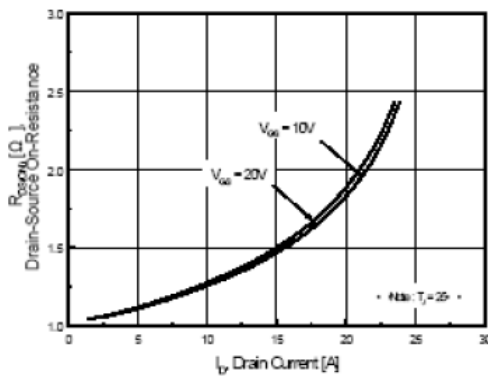


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

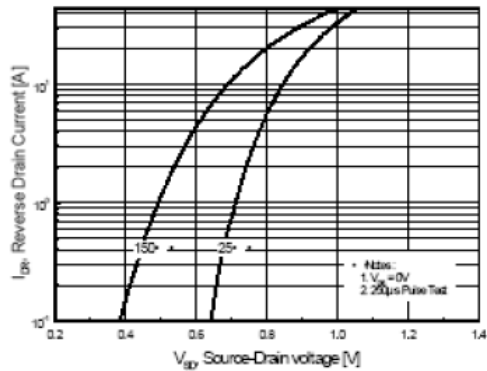


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

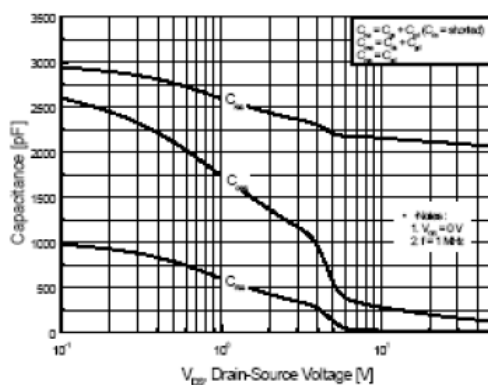


Figure 5. Capacitance Characteristics

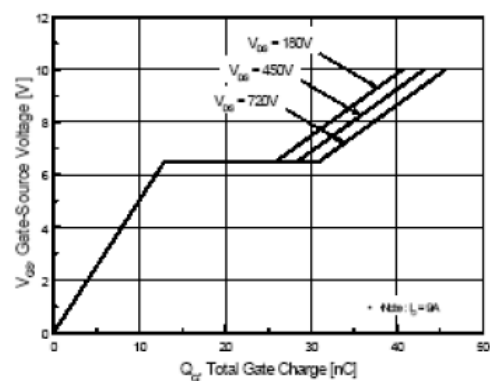


Figure 6. Gate Charge Characteristics

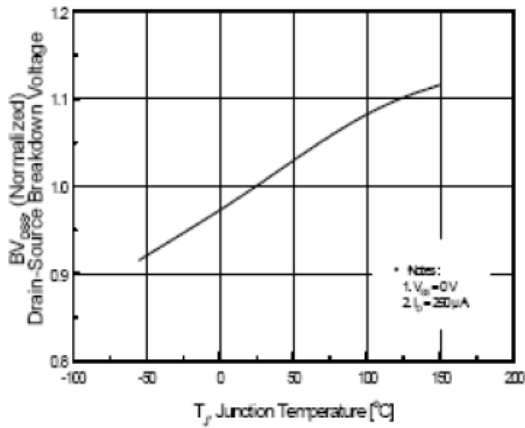


Figure 7. Breakdown Voltage Variation vs Temperature

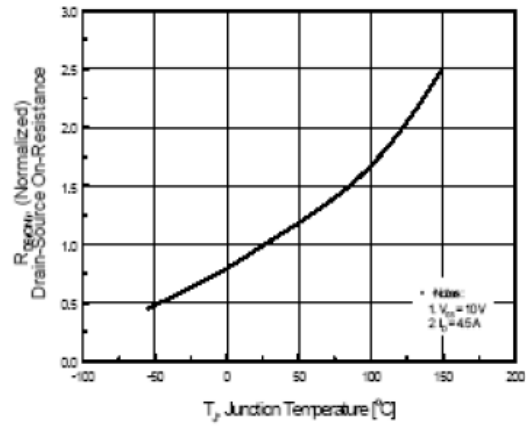


Figure 8. On-Resistance Variation vs Temperature

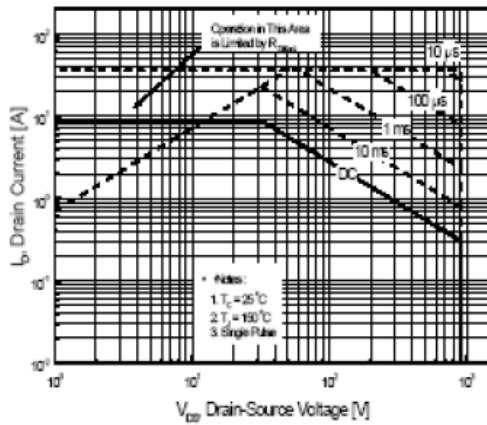


Figure 9. Maximum Safe Operating Area

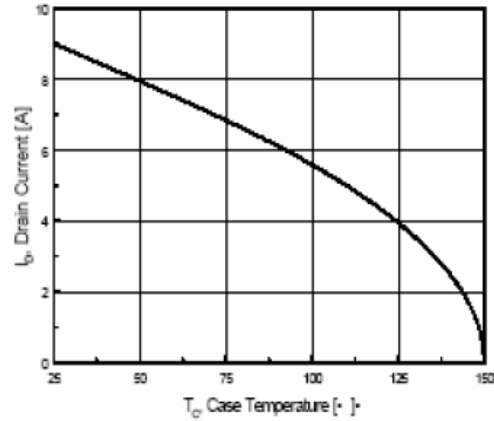


Figure 10. Maximum Drain Current vs Case Temperature

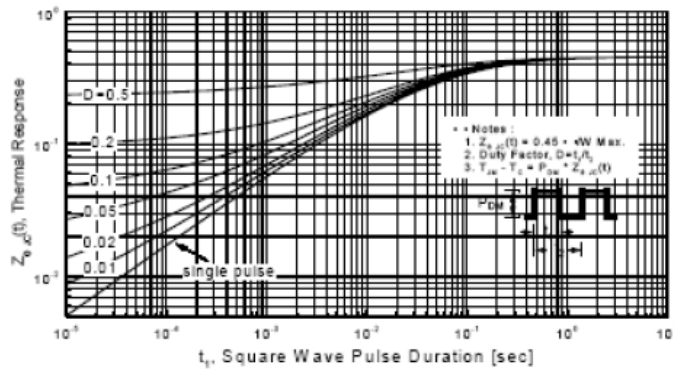


Figure 11. Transient Thermal Response Curve

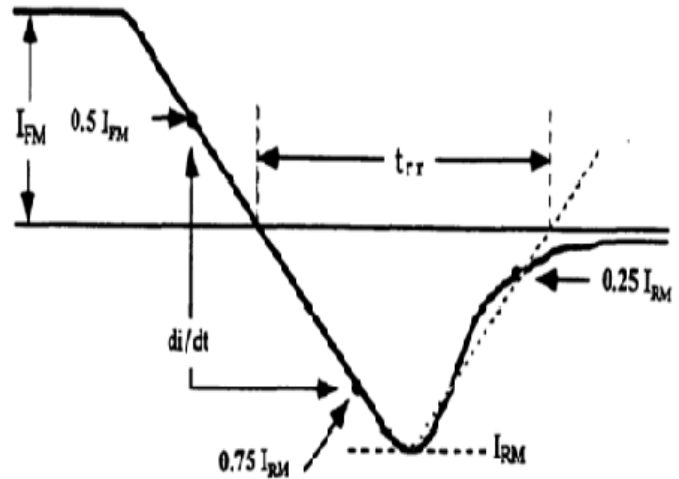
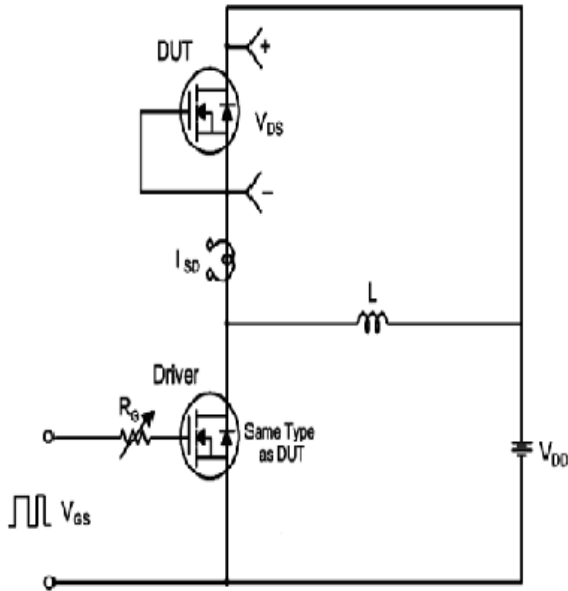


Fig12. Diode reverse recovery test circuit waveform

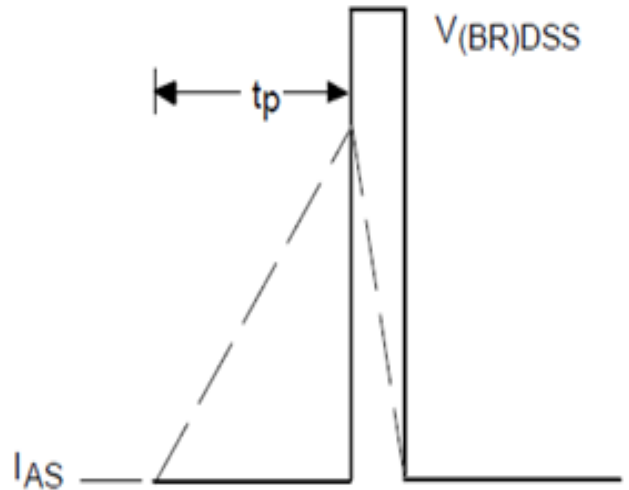
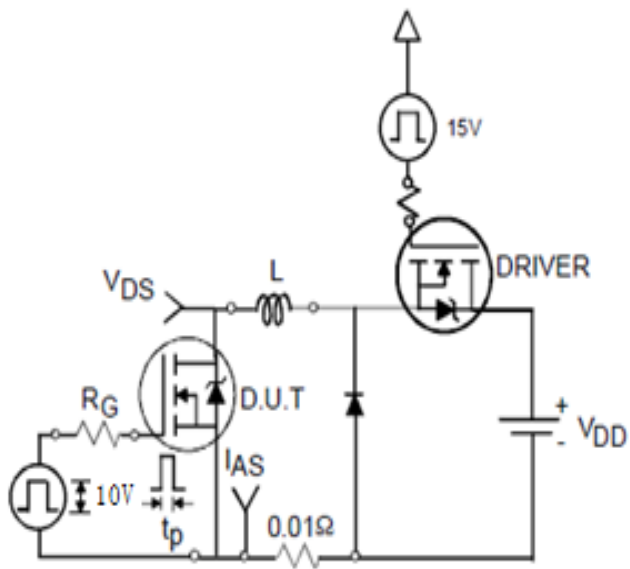


Fig13. Unclamped inductive test circuit waveform

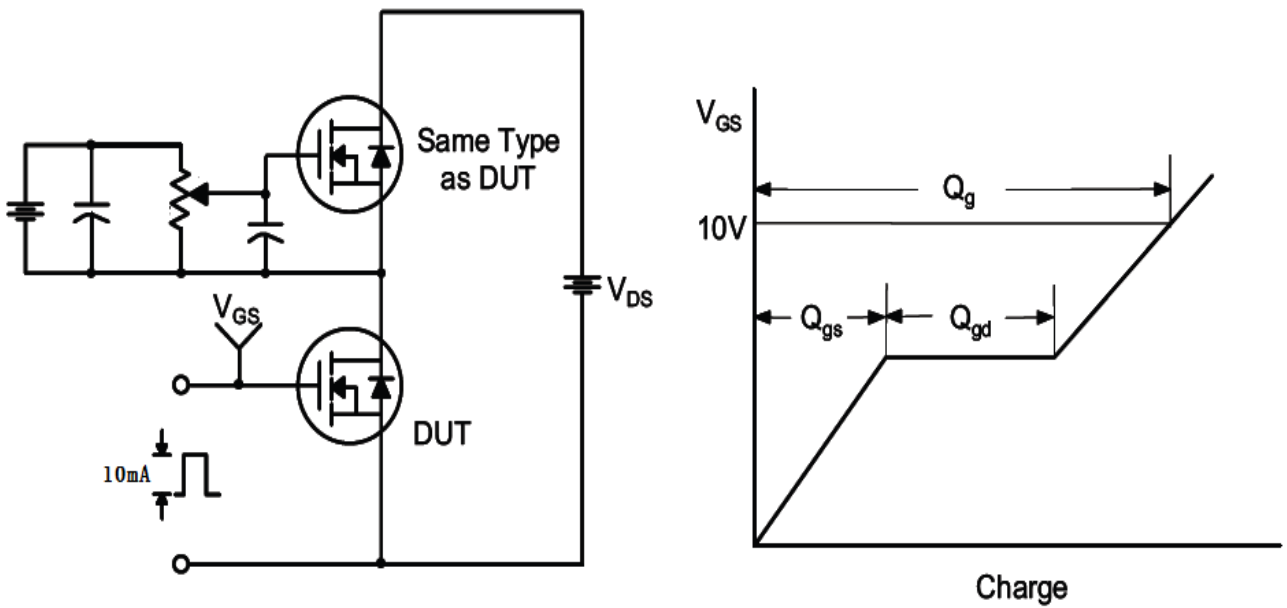


Fig14. Gate charge test circuit waveform

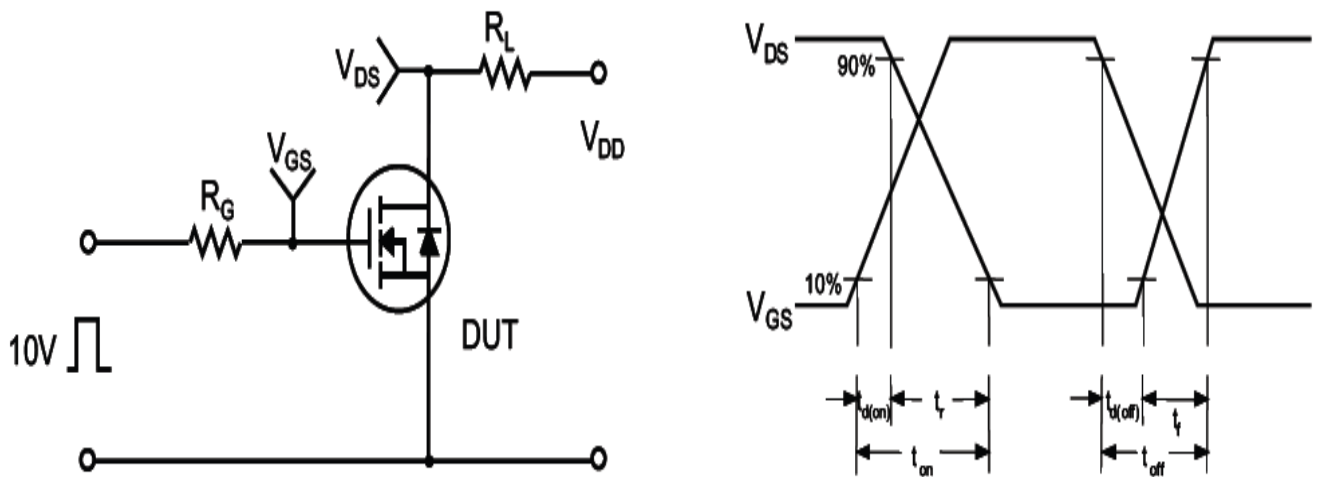
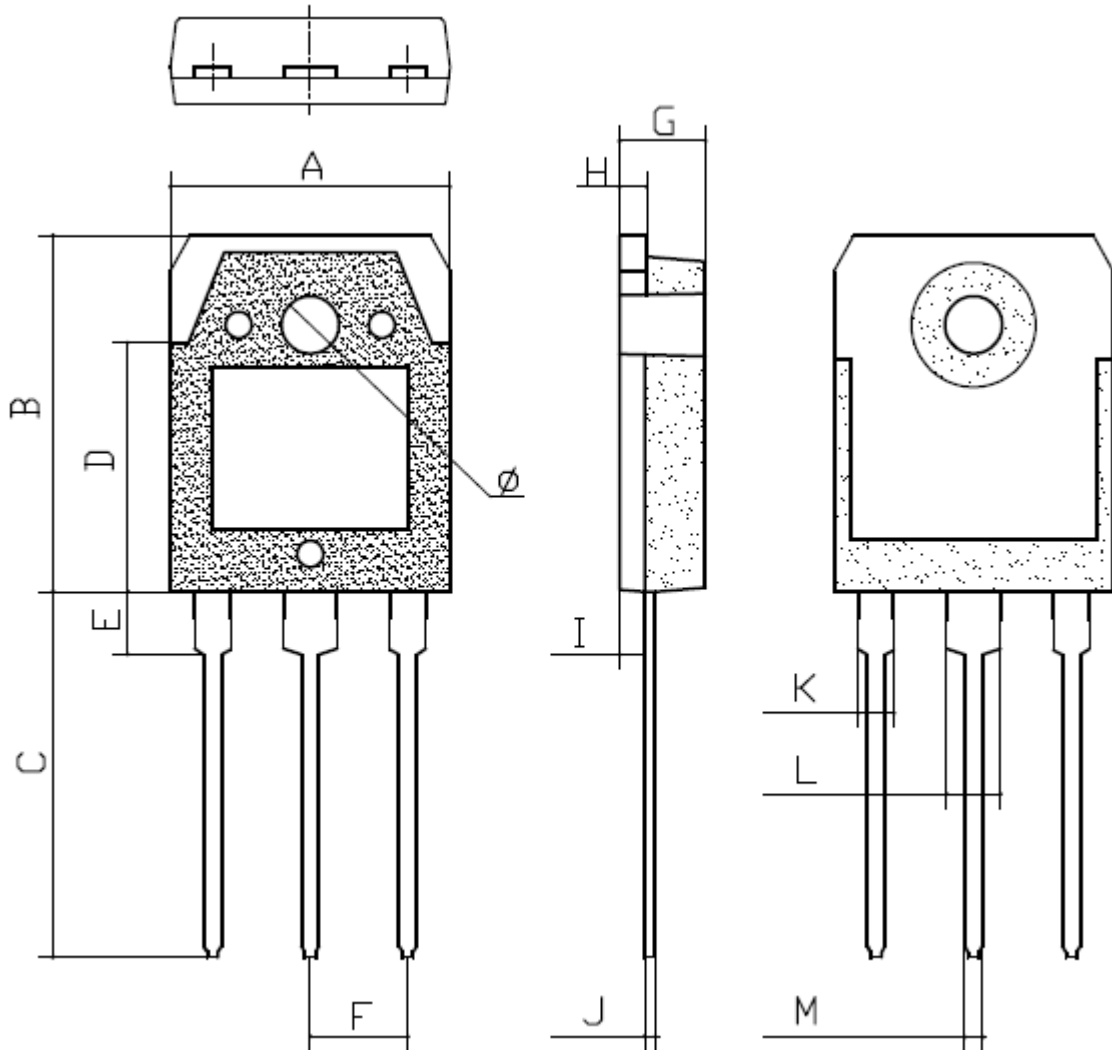


Fig15. Switching time waveform



TO3P PACKAGE OUTLINE



Ø	3.160	3.240	0.124	0.128
M	0.980	1.020	0.039	0.040
L	2.980	3.020	0.117	0.119
K	1.980	2.020	0.078	0.080
J	0.500	0.700	0.500	0.700
I	1.330	1.430	0.053	0.056
H	1.400	1.600	0.055	0.063
G	4.700	4.900	0.185	0.193
F	5.450 TYP		0.215 TYP	
E	3.480	3.520	0.137	0.139
D	13.800	14.000	0.543	0.551
C	20.300	20.500	0.799	0.807
B	19.800	20.000	0.780	0.787
A	15.500	15.700	0.610	0.618
Symbol	Min	Max	Min	Max
	Dimensions In Millimeters		Dimensions In Inches	

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